

Notice of References Cited

	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09/939,824	FUKUDA ET AL.
	Examiner Joseph Waks	Art Unit 2834

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	I	US-			
	J	US-			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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